

The University of Florida

has conferred on

Hao Wen

the degree

Master of Science

With a major in Electrical and Computer Engineering

and all the rights and privileges thereunto appertaining.

In Witness Whereof, this diploma, duly signed, has been issued
and the seal of the University affixed.

Issued by the Board of Trustees upon recommendation of the Faculty of

The Graduate School

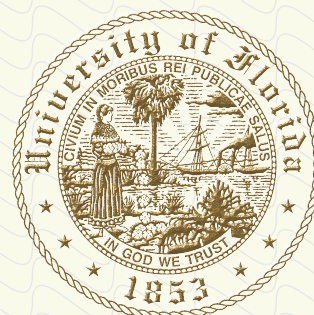
at Gainesville, this twenty-first day of December, 2021.



Ron DeSantis
Governor



Morteza Hosseini
Chairman Board of Trustees



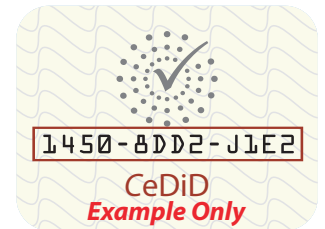
W. Kent Fuchs
President



Nicole H. Stedman
Dean

● *To validate this credential:*

Locate and note the CeDiD located in the upper left hand corner of the credential (page 1). The CeDiD is a unique identifier and is required for validation. Enter the CeDiD, using the link below to visit the institution's official validation website. Validation includes complete degree information that is time and date stamped by the issuing authority.



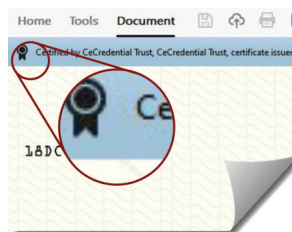
For more information
on CeCredential Trust, click [here](#).

Validate Now 

or visit student.ufl.edu/cediploma/validation

● *To verify the digital signature:*

This credential is certified by CeCredential Trust and should read as such. The ribbon signifies that both pages of this document have not been modified since issued. Do not trust this document if any other symbol is displayed.



Valid and certified
Authenticity and
integrity are verified
TRUST



Error!
Check internet
connection
DO NOT TRUST



Error!
Authenticity and
integrity not verified
DO NOT TRUST



Attestation of the Registrar

This **Certified Electronic Diploma (CeDiploma)** acknowledged herein represents satisfactory completion or attainment of education as authorized by the institution identified.



This CeDiploma (credential) has legal standing, is non-repudiating, and can be validated through the institution's website to provide absolute confidence in the credential's authenticity.

Questions should be directed to registrarhelp-l@lists.ufl.edu.